


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582833	<b>Applicant(s)/Patent Under Reexamination</b>  PEKKARINEN ET AL.
	<b>Examiner</b>  FEI FEI YEUNG LOPEZ	<b>Art Unit</b>  2826

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (inventor name search, 257/659, 361/220, and 257/355 with text search)	5/27/08	FYL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner